- Function and Pinout Compatible With FCT and F Logic
- Reduced V_{OH} (Typically = 3.3 V) Versions of Equivalent FCT Functions
- 25-Ω Output Series Resistors to Reduce Transmission-Line Reflection Noise
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I_{off} Supports Partial-Power-Down Mode Operation
- Matched Rise and Fall Times
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- Fully Compatible With TTL Input and Output Logic Levels
- 12-mA Output Sink Current
 15-mA Output Source Current
- Independent Register for A and B Buses
- 3-State Outputs

24 🛮 V_{CC} CPAB [SAB [23 II CPBA DIR 3 22 SBA 21 🛮 🗖 A_1 A_2 20 B₁ A_3 19 B₂ A_4 18 B₃ A₅ [17 B₄ A_6 16 B₅ A_7 15 B₆ 10 A₈ L 14 ∐ B₇ GND 13 B₈ 12

Q PACKAGE (TOP VIEW)

description

The CY74FCT2646T consists of a bus transceiver circuit with 3-state, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from the internal registers. Data on the A or B bus is clocked into the registers as the appropriate clock pin goes to a high logic level. Output-enable (\overline{G}) and direction-control (DIR) inputs determine the transceiver function. On-chip termination resistors at the outputs reduce system noise caused by reflections, so that the CY74FCT2646T can replace the CY74FCT646T in an existing design.

In the transceiver mode, data present at the high-impedance port can be stored in either the A or B register, or in both. Select controls (SAB, SBA) can multiplex stored and real-time (transparent mode) data. DIR determines which bus receives data when \overline{G} is active low. In the isolation mode (\overline{G} is high), A data can be stored in the B register and/or B data can be stored in the A register.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

PIN DESCRIPTION

NAME	DESCRIPTION
Α	Data register A inputs, data register B outputs
В	Data register B inputs, data register A outputs
СРАВ, СРВА	Clock pulse inputs
SAB, SBA	Output data source select inputs
DIR, G	Output-enable inputs



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



ORDERING INFORMATION

TA	PACKAGE†		SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	QSOP - Q	Tape and reel	5.4	CY74FCT2646CTQCT	FCT2646C
-40 C to 65 C	QSOP - Q	Tape and reel	6.3	CY74FCT2646ATQCT	FCT2646A

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

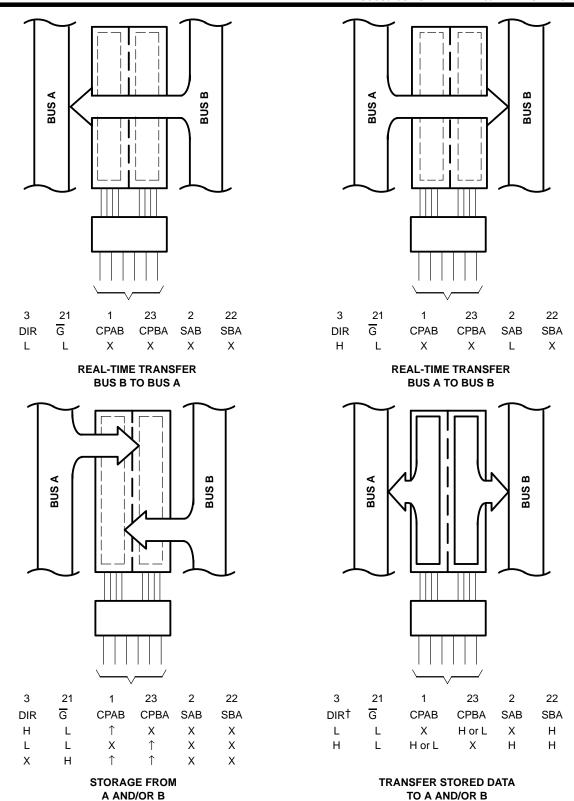
FUNCTION TABLE

		INPUTS					1/0‡	OPERATION OR
G	DIR	CPAB	СРВА	SAB	SBA	A ₁ -A ₈	B ₁ -B ₈	FUNCTION
Н	Χ	H or L	H or L	Χ	Χ	Input	Input	Isolation
Н	Χ	1	1	Χ	Χ	Input	Input	Store A and B data
L	L	Х	Х	Χ	L	Output	Input	Real-time B data to A bus
L	L	Χ	H or L	Χ	Н	Output	Input	Stored B data to A bus
L	Н	Х	Х	L	Х	Input	Output	Real-time A data to B bus
L	Н	H or L	Χ	Н	Χ	Input	Output	Stored A data to B bus

 $H = High logic level, L = Low logic level, X = Don't care, \uparrow = Low-to-high clock transition$



[‡] The data output functions can be enabled or disabled by various signals at the \overline{G} or DIR inputs. Data input functions always are enabled, i.e., data at the bus pins is stored on every low-to-high transition of the clock inputs.

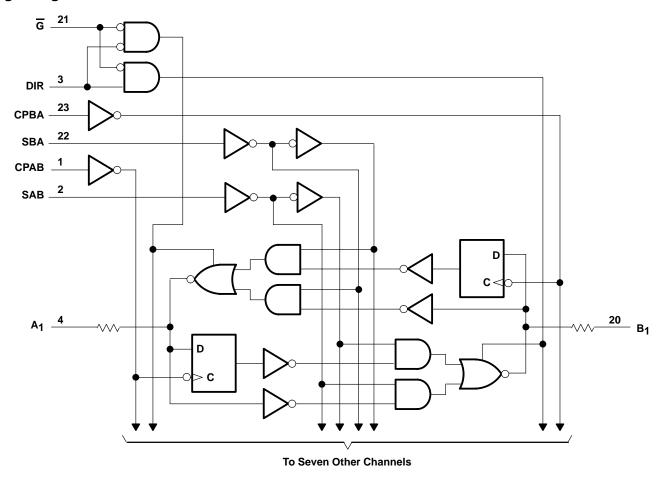


[†] Cannot transfer data to A bus and B bus simultaneously.

Figure 1. Bus-Management Functions



logic diagram



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range to ground potential	0.5 V to 7 V
DC input voltage range	0.5 V to 7 V
DC output voltage range	0.5 V to 7 V
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, θ _{JA} (see Note 1)	61°C/W
Ambient temperature range with power applied, T _A	–65°C to 135°C
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.75	5	5.25	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
IOH	High-level output current			-15	mA
loL	Low-level output current			12	mA
T _A	Operating free-air temperature	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	3	MIN	TYP [†]	MAX	UNIT
VIK	$V_{CC} = 4.75,$	I _{IN} = -18 mA			-0.7	-1.2	V
VOH	$V_{CC} = 4.75,$	I _{OH} = -15 mA		2.4	3.3		V
V _{OL}	$V_{CC} = 4.75,$	I _{OL} = 12 mA			0.3	0.55	V
R _{out}	$V_{CC} = 4.75,$	I _{OL} = 12 mA		20	25	40	Ω
V _{hys}	All inputs				0.2		V
ήн	V _{CC} = 5.25 V	$V_{IN} = V_{CC}$ $V_{IN} = 2.7 \text{ V}$				5 ±1	μΑ
I _{IL}	V _{CC} = 5.25 V,	V _{IN} = 0.5 V				±1	μΑ
lozh	V _{CC} = 5.25 V,	V _{OUT} = 2.7 V				10	μΑ
lozL	V _{CC} = 5.25 V,	V _{OUT} = 0.5 V				-10	μΑ
los [‡]	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 0 V		-60	-120	-225	mA
l _{off}	$V_{CC} = 0 V$,	V _{OUT} = 4.5 V				±1	μΑ
Icc	$V_{CC} = 5.25 \text{ V},$	$V_{IN} \le 0.2 V$,	$V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.1	0.2	mA
ΔlCC	$V_{CC} = 5.25 \text{ V}, V_{IN} = 3.25 \text{ V}$	3.4 V , $f_1 = 0$, Outputs op	en		0.5	2	mA
ICCD¶	$\frac{V_{CC}}{G}$ = 5.25 V, One in $\frac{V_{CC}}{G}$ = DIR = GND, GAE	pu <u>t swit</u> ching at 50% duty S = GBA = GND, V _{IN} ≤ 0.2	cycle, Outputs open, 2 V or $V_{IN} \ge V_{CC} - 0.2 V$		0.06	0.12	mA/ MHz
	V _{CC} = 5.25 V,	One input switching at f ₁ = 5 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.7	1.4	
IC#	Outputs open,	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1.2	3.4	mA
ıÇ	$\overline{G} = DIR = GND,$ $GAB = \overline{GBA} = GND$	Eight bits switching at f ₁ = 5 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		2.8	5.6	ША
		at 50% duty cycle	V _{IN} = 3.4 V or GND		5.1	14.6	
C _i					6	10	pF
Co					8	12	pF

[†] Typical values are at V_{CC} = 5 V, T_A = 25°C.

= Total supply current IC.

I_{CC} = Power-supply current with CMOS input levels

ΔICC = Power-supply current for a TTL high input (VIN = 3.4 V)

D_H = Duty cycle for TTL inputs high = Number of TTL inputs at DH

ICCD = Dynamic current caused by an input transition pair (HLH or LHL)

= Clock frequency for registered devices, otherwise zero f_0

f₁ = Input signal frequency

= Number of inputs changing at f₁

All currents are in milliamperes and all frequencies are in megahertz.

Values for these conditions are examples of the ICC formula.



[‡] Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

[§] Per TTL-driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND

This parameter is derived for use in total power-supply calculations.

[#]IC = $ICC + \Delta ICC \times DH \times NT + ICCD (f_0/2 + f_1 \times N_1)$ Where:

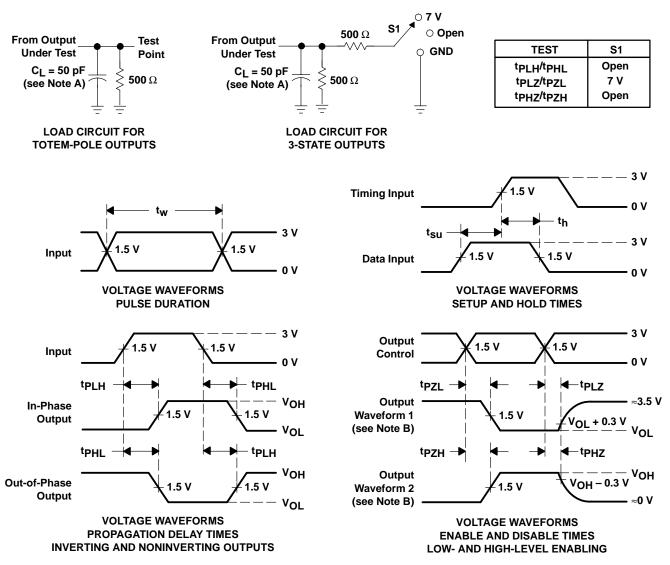
timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 2)

			CY74FCT2	2646AT	CY74FCT2	2646CT	UNIT
			MIN	MAX	MIN	MAX	UNIT
t _W	Pulse duration, high or low		5		5		ns
t _{su}	Setup time, high or low	Data before CPBA↑ or CPAB↑	2		2		ns
t _h	Hold time, high or low	Data after CPBA↑ or CPAB↑	1.5		1.5		ns

switching characteristics over operating free-air temperature range (see Figure 2)

PARAMETER	FROM	то	CY74FCT	2646AT	CY74FCT	2646CT	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT	
^t PLH	A or B	B or A	1.5	6.3	1.5	5.4	ns	
^t PHL	AOID	BOIA	1.5	6.3	1.5	5.4	115	
^t PZH	G	A or B	1.5	9.8	1.5	7.8	ns	
t _{PZL}	9	AUID	1.5	9.8	1.5	7.8	115	
^t PZH	DIR	A or B	1.5	9.8	1.5	7.8	ns	
t _{PZL}	DIK	AOIB	1.5	9.8	1.5	7.8	115	
t _{PHZ}	G	A or B	1.5	6.3	1.5	6.3	ns	
tPLZ	G	AUID	1.5	6.3	1.5	6.3	115	
^t PHZ	DIR	A or B	1.5	6.3	1.5	6.3	ns	
^t PLZ	DIK	AUID	1.5	6.3	1.5	6.3	115	
^t PLH	CPAB or CPBA	B or A	1.5	6.3	1.5	5.7		
^t PHL	CPAD OF CPBA	D OT A	1.5	6.3	1.5	5.7	ns	
^t PLH	SAB or SBA	B or A	1.5	7.7	1.5	6.2	200	
^t PHL	SAD UI SBA	D UI A	1.5	7.7	1.5	6.2	ns	

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms







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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74FCT2646ATQCTE4	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT2646ATQCT	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT2646CTQCT	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT2646CTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY74FCT2646CTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN74FCT2646ATQCTG4	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

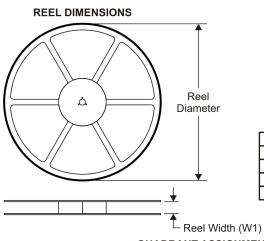
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT2646ATQCT	SSOP/ QSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT2646CTQCT	SSOP/ QSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1





*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT2646ATQCT	SSOP/QSOP	DBQ	24	2500	346.0	346.0	33.0
CY74FCT2646CTQCT	SSOP/QSOP	DBQ	24	2500	346.0	346.0	33.0

DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.



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